Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

# 2SK2967

# DC-DC Converter, Relay Drive and Motor Drive Applications

• Low drain-source ON resistance : RDS (ON) = 48 m $\Omega$  (typ.)

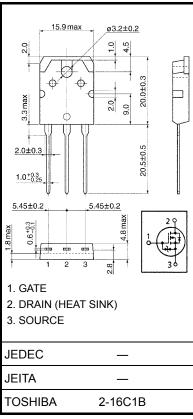
• High forward transfer admittance  $: |Y_{fs}| = 30 \text{ S (typ.)}$ 

• Low leakage current  $: I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 250 \text{ V)}$ 

• Enhancement mode :  $V_{th} = 1.5 \sim 3.5 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$ 

### **Absolute Maximum Ratings (Ta = 25°C)**

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	250	V	
Drain-gate voltage (Ro	<sub>SS</sub> = 20 kΩ)	$V_{DGR}$	250	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	30	Α	
	Pulse (Note 1)	I <sub>DP</sub>	120	Α	
Drain power dissipation	n (Tc = 25°C)	P <sub>D</sub>	150	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	925	mJ	
Avalanche current		I <sub>AR</sub>	30	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	15	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	0.833	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 50 V,  $T_{ch}$  = 25°C (initial), L = 1.74 mH,  $I_{AR}$  = 30 A,  $R_G$  = 25  $\Omega$ 

Note 3: Repetitive rating: pulse width limited by maximum channel temperature.

This transistor is an electrostatic-sensitive device.

Please handle with caution.



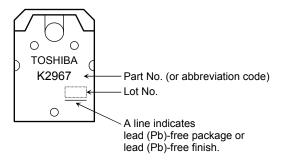
## **Electrical Characteristics (Ta = 25°C)**

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V	-	_	100	μΑ
Drain-source br voltage	eakdown	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	250	_	_	V
Gate threshold v	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.5	V
Drain-source Ol	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A		48	68	mΩ
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 15 A	15	30	_	S
Input capacitano	e	C <sub>iss</sub>			5400	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		580	_	
Output capacitance		Coss	1		1900	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} \stackrel{10V}{\underset{OV}{\text{OV}}} \stackrel{I_{D}=15A}{\underset{R_{L}=}{\text{OVOUT}}} V_{DD} \stackrel{=}{\Rightarrow} 100V$	_	20	_	
	Turn-on time	t <sub>on</sub>		-	50	_	
	Fall time	t <sub>f</sub>		_	35	_	ns
	Turn-off time	t <sub>off</sub>	Duty $\leq 1\%$ , $t_{\mathbf{w}} = 10 \mu s$	-	200	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	132	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 200 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		80		nC
Gate-drain ("miller") Charge		Q <sub>gd</sub>			52	_	

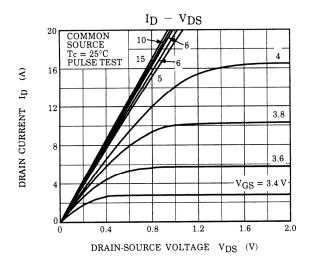
## **Source-Drain Ratings and Characteristics (Ta = 25°C)**

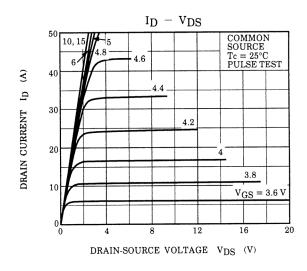
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	-	_	30	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	120	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 30 A, V <sub>GS</sub> = 0 V	ı	_	-2.0	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 30 A, V <sub>GS</sub> = 0 V	l	270	1	ns
Reverse recovery charge	Qrr	dl <sub>DR</sub> / dt = 100 A / μs	_	3.0	_	μC

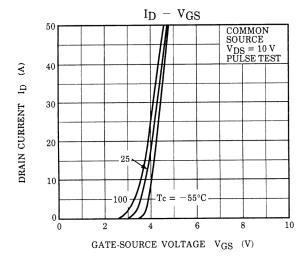
## Marking

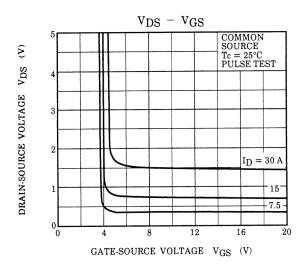


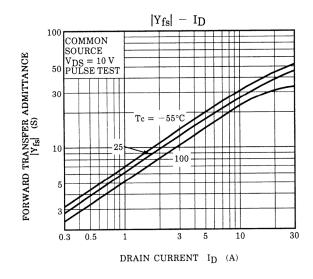
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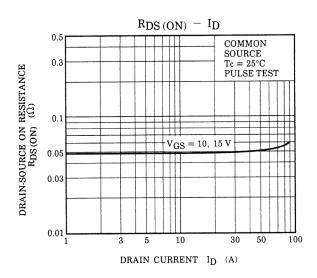


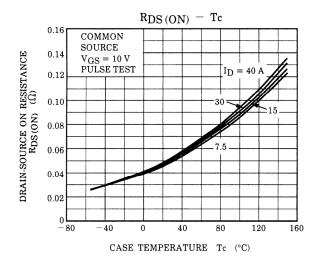


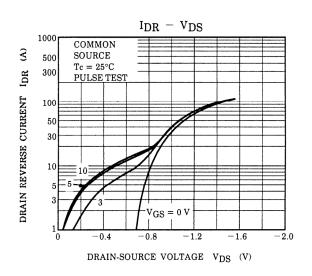


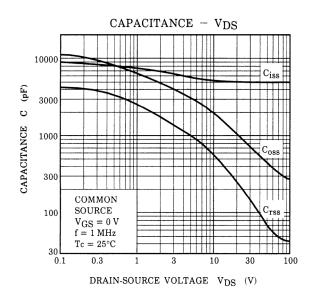


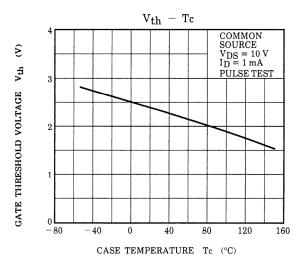


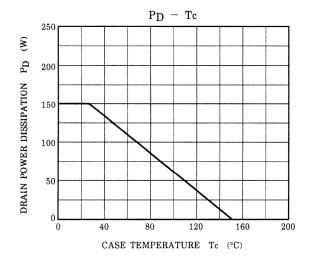


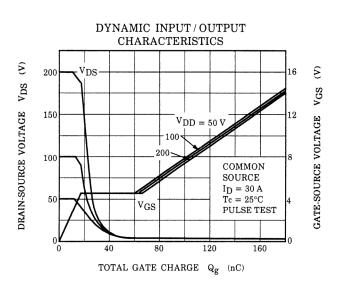


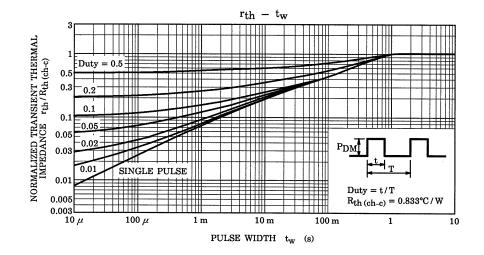


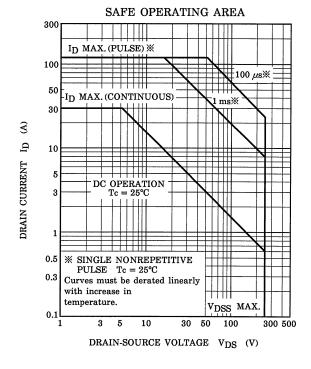


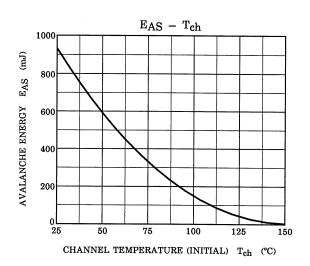


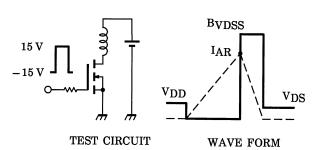












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 50~V,~L = 1.74~mH \end{aligned} \qquad E_{AS} &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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